## Notice of References Cited Application/Control No. 10/042,780 Applicant(s)/Patent Under Reexamination VANDENAMEELE-LEPLA, PATRI Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,628,738	09-2003	Peeters et al.	375/371
	В	US-6,862,262	03-2005	Imamura, Daichi	370/210
	С	US-			•
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					•
	0	-				
	Р					
	α					•
	R					
	S					·
	Т					

## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V				
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	х				

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